

Supporting Information

Role of Oxygen Vacancy Ordering and Channel Formation in Tuning Intercalation Pseudocapacitance in Mo Single-Ion Implanted CeO_{2-x} Nanoflakes

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EXPERIMENTAL SECTION

Sample Fabrication: Modified cathodic chronopotentiometric electrodeposition (MCCE) was done using a classical three-electrode configuration system. Ni foam with a true porosity of ~96% (Wuhan Geao Scientific Education Instrument, Wuhan, China), platinum (Basi Inc., Evansville, IN, USA, coil wire L = 23 cm, Ø = 0.5 mm), and Ag/AgCl (Basi Inc., Evansville, IN, USA) were used as the working, counter, and reference electrodes, respectively. All potentials were based on the Ag/AgCl reference electrode. The electrolyte was prepared by mixing Ce(NO₃)₆·6H₂O (0.1 M; 99.0%) and (NH₄NO₃) (0.1 M; ≥99.0%), which were purchased from Sigma Aldrich (City, Country), in 100 mL of deionised (DI) water. The pH was adjusted to 6 using 1 M NaOH, also obtained from the same supplier. Prior to electrodeposition, the Ni foam substrate was cleaned by ultrasonication in HCl (1 M) for 10 min, followed by rinsing with (DI) water and drying with compressed nitrogen. The nominal dimensions of the Ni foam were 10 mm × 5 mm × 2 mm. The potentiostat (EZstat Pro, Nuvant Systems, Crown Point, IN, USA) had a resolution of 300 µV and 3 nA in the ±100 µA range. The electrodeposited samples were stored in a desiccator with silica gel prior to analysis. The electrodeposition was done at -1 V vs Ag/AgCl for 20 min and the temperature of the electrolyte was held at 65°C using a water bath.

Mo Ion Implantation: Mo ion implantation under vacuum was done using the low-energy ion-implantation (LEII) beamline attached to the SIRIUS 6 MV accelerator at the Australian Nuclear Science and Technology Organization (ANSTO), as shown in **Figure S1**. The Dynamic-TRIM software code was used prior to experimentation in order to determine the implantation energy required for implantation depths of 20-40 nm. To this end, an accelerating energy of 10 keV and a dosage of 1 × 10¹⁵ atoms·cm⁻² were used. The LEII implanter system operates using a Penning sputter source to

generate and extract the required ions from solid cathode targets. These ions are mass separated using a 90° electromagnet and subsequently focussed by electrostatic Einzel and quadrupole lenses onto the sample located in the end station experiment chamber. The beam then is electrostatically raster-scanned over the sample to perform implantation under a vacuum of 1×10^{-4} Pa. Since the amount of CeO₂ deposit was so small, quantitative analysis to determine the Mo dopant concentration was not possible. Consequently, it was calculated using the Mo dosage (1×10^{15} atoms·cm⁻²), the weight gain from CeO₂ formation on all Ni surfaces (0.15 mg), image analysis (4 mm x 4 mm SEM image; *Image J* image analysis) to determine the 2D solid cross sectional area of the Ni foam (74 areal%), and halving this amount in order to account for ion implantation only on the top half of the foam struts. This calculation yields an Mo dopant concentration of ~1.7 mol%, which is similar that that used in other studies reported the effects of Mo doping by more conventional methods (1.0-2.0 mol%).¹⁻³

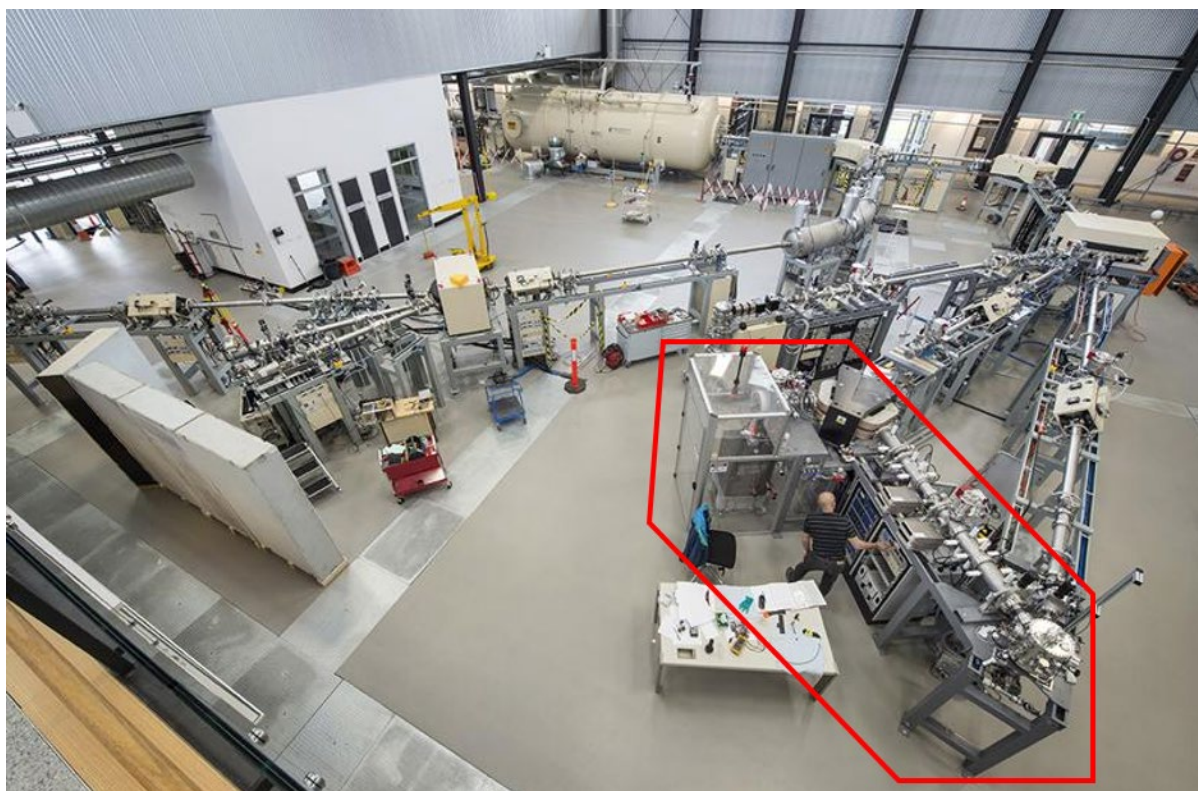


Figure S1 Photo of SIRIUS 6 MV accelerator at the Australian Nuclear Science and Technology Organization (ANSTO) with the Low Energy Ion Implanter system outlined in red.

Materials Characterisation: Mineralogical and defect data for the films were obtained by laser Raman microspectroscopy (Raman; Renishaw in Via Raman microscope, Wotton-under-Edge, Gloucestershire, UK, beam diameter 1.5 μ m), which was equipped with a 35 mW helium-neon green laser (514 nm) in the range 200-800 cm⁻¹. The spectra were fitted and calibrated using Renishaw WiRE 4.3 software. The nanostructures of the samples were analysed using high-resolution transmission electron microscopy (HRTEM; Philips CM 200, Eindhoven, Netherlands, accelerating voltage 5 kV)

and selected area electron diffraction (SAED). Nanostructural images were obtained by scanning electron microscopy (SEM; FEI Nova NanoSEM, Hillsboro, OR, USA, secondary electron emission, accelerating voltage 5 kV). Local chemical analyses were done using energy dispersive spectroscopy (EDS; Hillsboro, OR, USA). Surface chemical analyses and defect data were obtained using X-ray photoelectron spectroscopy (XPS; ESCALAB 250Xi spectrometer, Thermo Fisher Scientific, Loughborough, Leicestershire, UK, 13 kV, 12 mA, spot size 500 μm). Defect data also were obtained using photoluminescence spectroscopy (PL; RF-5301PC spectrofluorophotometer, Shimadzu, Kyoto, Japan). The thickness was assessed by atomic force microscopy (AFM; Bruker Dimension Icon SPM, Bruker, Billerica, MA, USA, tapping mode, nominal tip radius 7 nm). A Bruker ScanAsyst-Air probe was installed with the AFM holder and used for all measurements. The scan size was set at 10 μm with an aspect ratio of 4. The pixel resolution was 512 samples/line for all scans. The scan rate was ~ 0.195 Hz since this slow scan rate ensured greater accuracy of the measurements. The chemical species present in the Ni foam were detected using Fourier transform infrared spectroscopy (FTIR; Spotlight 400 FTIR, PerkinElmer, Waltham, MA, USA) in the wavelength range 450-4000 cm^{-1} . The solubility of Mo was confirmed using proton-induced X-ray emission (PIXE; 2MV STAR tandem accelerator, High Voltage Engineering Europa, Amersfoort, Netherlands) with 2.6 MeV protons and $\sim 10\text{-}15$ nA current. The X-rays were detected using an Si(Li) detector fitted with a standard 25 μm thickness Be window and additional pinhole filter to decrease further the intensity of the X-rays excited by the low-Z elements with high cross sections; a 50 μC charge was acquired for each sample.

First Principles Calculations: Structural optimisations were performed using the full-potential, linearised, augmented, plane-wave method, as implemented in the WIEN2k code.^{4,5} A non-shifted $10 \times 10 \times 10$ k-point mesh, with $RK_{\text{max}} = 7.0$; muffin tin radii of 2.3 and 1.98 Bohr for Ce and O ions, respectively; and the semi-local Perdew-Burke-Ernzerhof (PBE) energy functional were used to determine the ground state structures of stoichiometric and nonstoichiometric CeO_{2-x} .^{6,7} The calculations were performed on a supercell containing 24 atoms for the pristine (stoichiometric) system. Ground-state nonstoichiometric configurations were determined by exploring all possible oxygen vacancy arrangements in the pristine Ce_8O_{16} simulation cell.⁸ Accurate densities of states and other electronic properties were obtained using spin-polarised single-point energy calculations on the geometries determined at the PBE functional level using a nonshifted $50 \times 50 \times 50$ k-point mesh and modified Tran-Blaha Becke-Johnson energy functional (TB-mBJ).⁹⁻¹¹ These TB-mBJ results then were used with the modified-BoltzTraP code,¹² which solves the Boltzmann transport equation, in order to calculate electronic conductivities. Electron-phonon dynamical matrices were computed using the Quantum Espresso code in order to estimate charge carrier relaxation times.¹³ For these types of calculations, ultrasoft pseudopotentials (from PP library v1.0), 888 k-points, an energy cut-off of 38 Ry, and a Methfessel-Paxton first-order smearing of 0.03 Ry were used.¹⁴ The average electron-phonon dynamical matrices then were calculated using the EPA code.¹⁵ Finally, the ionic diffusivities of oxygen

ions were estimated as a function of composition and temperature (300°-1200°C) using the classical molecular dynamics code LAMMPS and the CeO₂ force field reported in previous work.^{16,17}

Spin-polarized First Principles calculations for Band Energy : Density functional theory (DFT) calculations were carried out to theoretically characterize the electronic properties of Mo dopants (substitutional and interstitial) and oxygen vacancies in CeO₂.¹⁸ The PBEsol functional as it is implemented in the VASP software was used.^{19,20} A “Hubbard-*U*” scheme with $U = 3$ eV was employed for a better treatment of the localized Ce 4*f* and Mo 4*d* electronic orbitals. The “projector augmented wave” method was used to represent the ionic cores by considering the following electrons as valence: Ce 4*f*, 5*d*, 6*s*, and 4*d*; Mo 4*d* and 5*s*; and O 2*s* and 2*p*.^{21,22} Wave functions were represented in a plane-wave basis truncated at 650 eV. For integrations within the first Brillouin zone a Monkhorst-Pack k-point grid was used with a density equivalent to that of $16 \times 16 \times 16$ for the fluorite CeO₂ unit cell. Periodic boundary conditions were applied along the three lattice vectors defining the simulation supercell; geometry relaxations were performed with a conjugate-gradient algorithm that optimized the ionic positions and the volume and shape of the simulation cell. The relaxations were halted when the forces in the atoms were all below $0.01 \text{ eV} \cdot \text{\AA}^{-1}$. By using these technical parameters, the obtained energies were converged to within 0.5 meV per formula unit. The range-separated hybrid HSE06 exchange-correlation functional was employed to accurately estimate the electronic energy levels of the equilibrium geometries generated with the PBE sol+*U* functional.²³ The value of the theoretical valence and conduction energy band edges referred to the Fermi energy level were determined through analysis of the projected densities of electronic states obtained in the DFT calculations. A conventional CeO₂ fluorite unit cell containing 12 ions (with chemical formula Ce₄O₈) was used in all our DFT simulations. The Mo interstitial and substitutional concentrations were fixed to 20% and the position of the interstitial ions coincided with the high-symmetry octahedral fluorite sites ($\frac{1}{2}, \frac{1}{2}, \frac{1}{2}$) in pseudo-Cartesian notation. The reduced species Mo⁵⁺ and Mo⁴⁺ (charged oxygen vacancies) were generated by adding supplementary (removing) electrons to (from) the system.

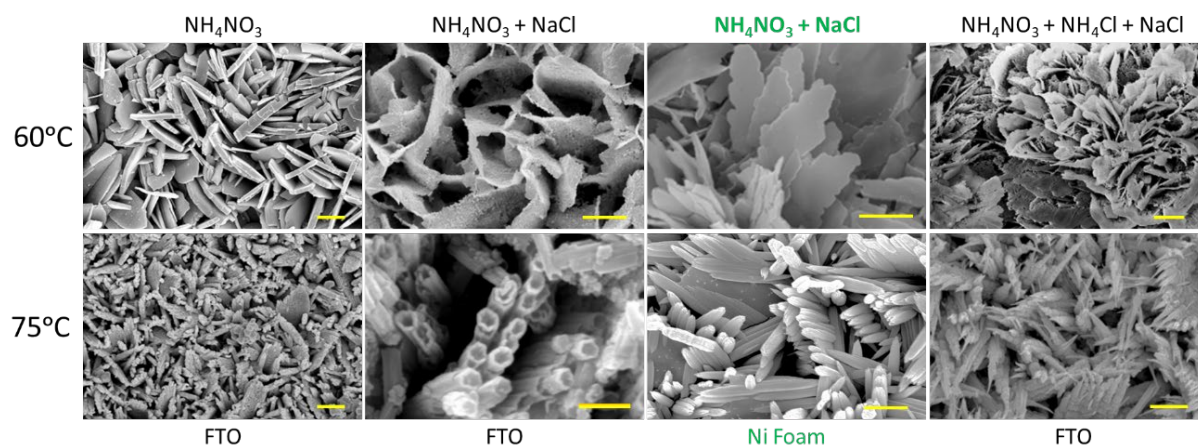


Figure S2 SEM images of different morphologies CeO_{2-x} as a function of experimental parameters (precursor type, temperature, substrate type) (scale bar = 300 nm)

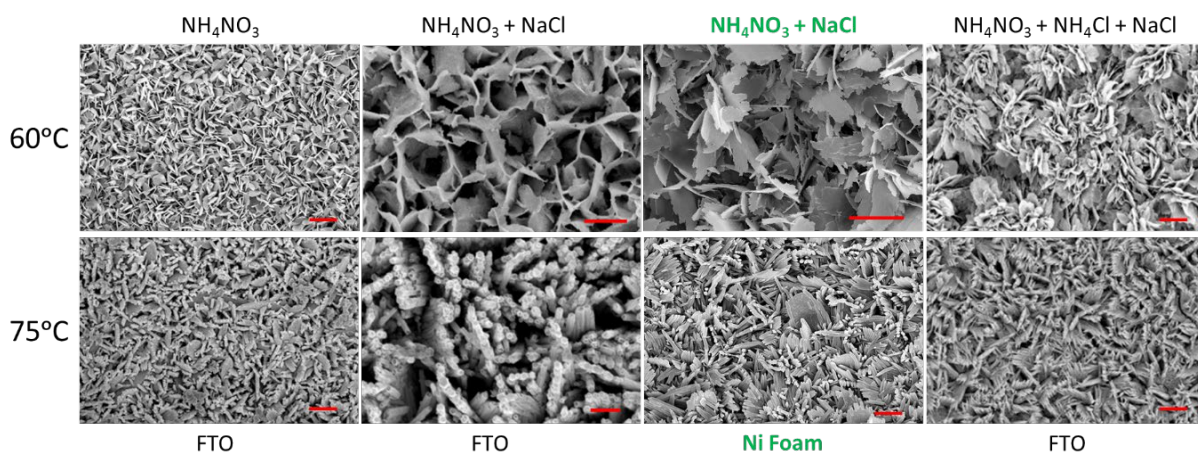


Figure S3 Enlarged SEM images of **Figure S2** (scale bar = 3 μm)

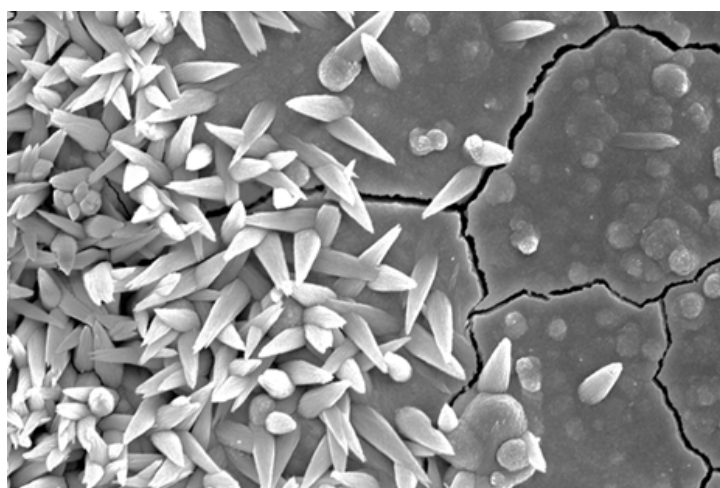


Figure S4 Ni foam with as-electrodeposited CeO_{2-x} after 5 min (left) and cracked surface layer (right)

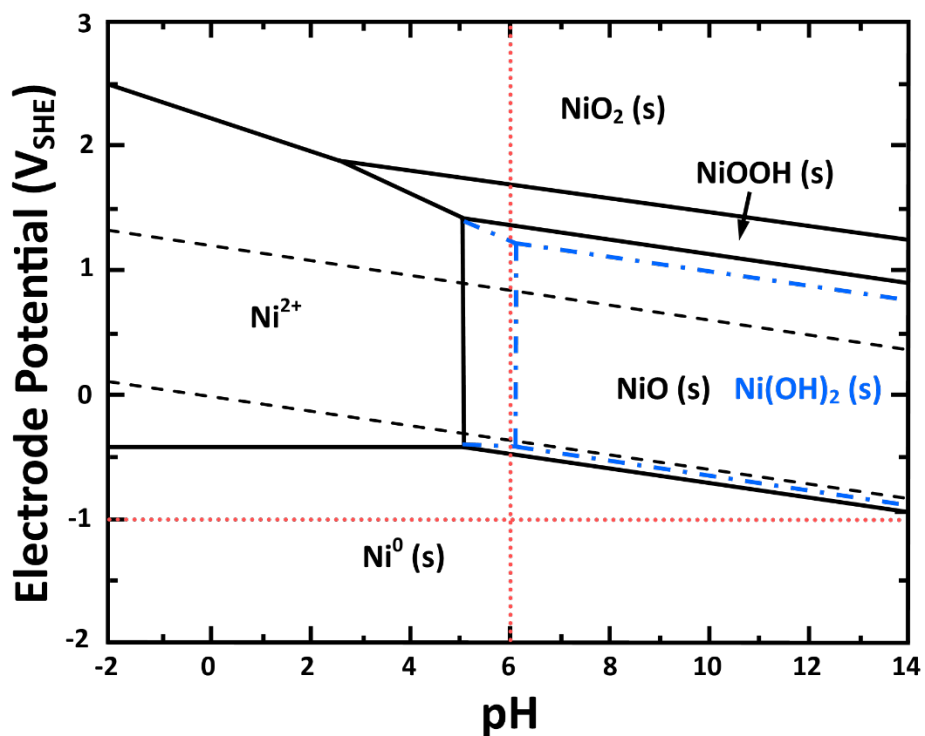


Figure S5 Ni – H₂O Pourbaix diagram ($Ni(OH)_2$ predominance region overlaps (blue dash-dot lines) because both $NiO(s)$ and $Ni(OH)_2$ occur simultaneously), adapted from ²⁴ (NiO red dotted line = experimental conditions)

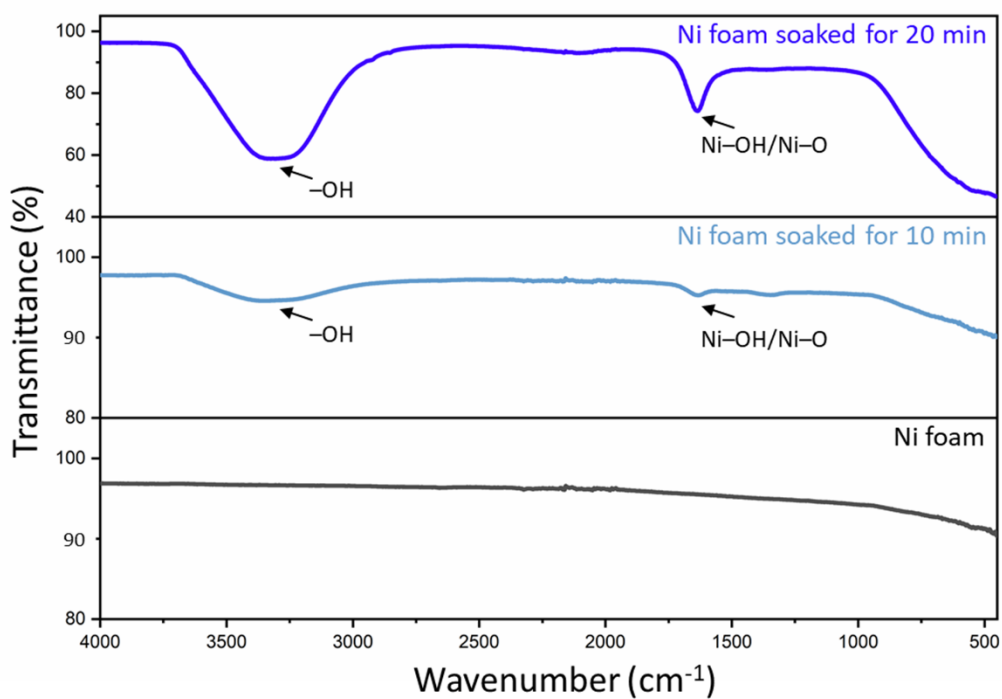


Figure S6 FTIR data of Ni foam soaked for 0, 10 and 20 min.

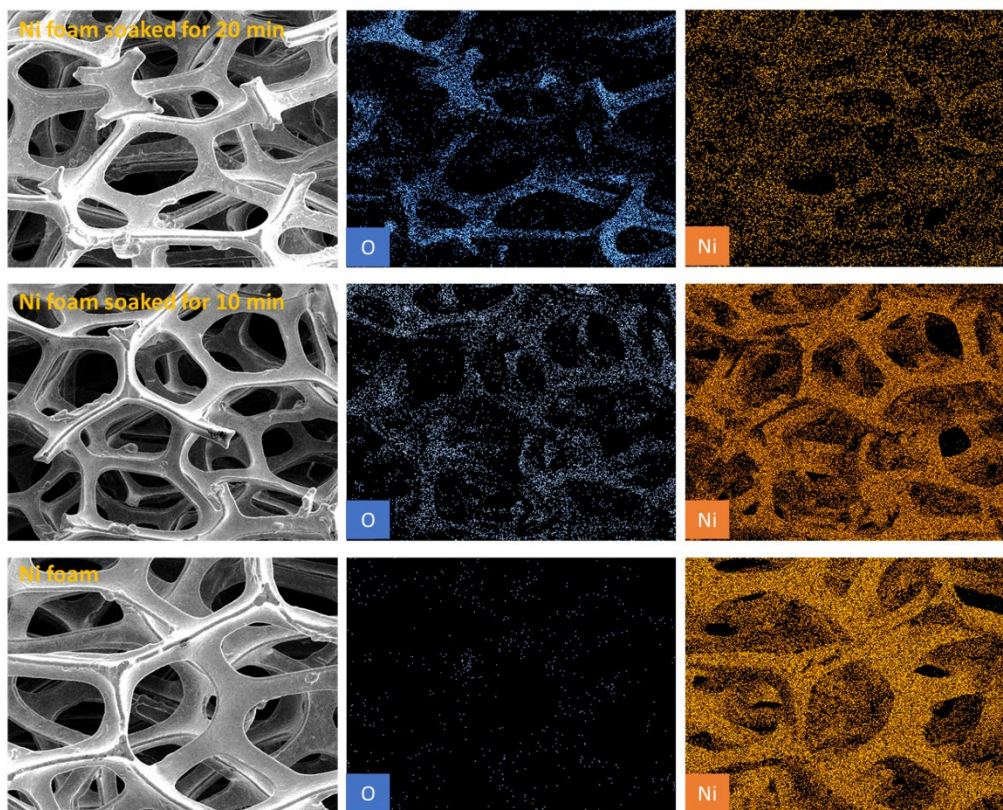


Figure S7 EDS mapping of Ni foam soaked for 0, 10, and 20 min

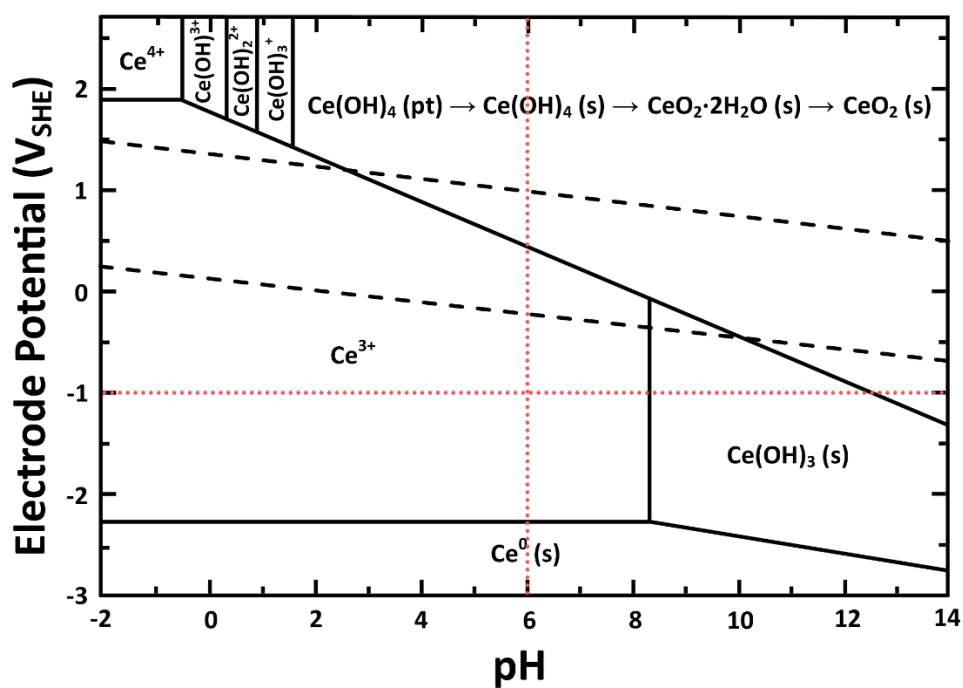


Figure S8 Ce – H₂O Pourbaix diagram, adapted from ²⁵

Table S1. Potential extrinsic defect equilibria for Mo- or Ni-doped of CeO_{2-x}.²⁶

Dopant	Solid Solubility	Process	Extrinsic Defect Equilibria
Mo	Substitutional	Ionic Charge Compensation	$4\text{Mo}_{\text{Mo}}^{\times} + 100\text{O}_0^{\times} \xrightarrow{\text{CeO}_2} 4\text{Mo}_{\text{Ce}}^{\bullet} + \text{V}_{\text{Ce}}^{\prime\prime\prime\prime} + 5\text{Ce}_{\text{S}}^{\times} + 100\text{O}_0^{\times}$
		Electronic Charge Compensation	$2\text{Mo}_{\text{Mo}}^{\times} + 50\text{O}_0^{\times} \xrightarrow{\text{CeO}_2} 2\text{Mo}_{\text{Ce}}^{\bullet} + 2\text{Ce}_{\text{S}}^{\times} + 40\text{O}_0^{\times} + \frac{1}{2}\text{O}_2(\text{g}) + 2e'$
		Redox Charge Compensation	$2\text{Mo}_{\text{Mo}}^{\times} + 50\text{O}_0^{\times} \xrightarrow{\text{CeO}_2} 2\text{Mo}_{\text{Ce}}^{\bullet} + 2\text{Ce}_{\text{S}}^{\times} + 40\text{O}_0^{\times} + \frac{1}{2}\text{O}_2(\text{g}) + 2\text{Ce}'_{\text{Ce}}$
	Interstitial	Ionic Charge Compensation	$4\text{Mo}_{\text{Mo}}^{\times} + 100\text{O}_0^{\times} \xrightarrow{\text{CeO}_2} 4\text{Mo}_{\text{i}}^{\bullet\bullet\bullet\bullet} + 5\text{V}_{\text{Ce}}^{\prime\prime\prime\prime} + 5\text{Ce}_{\text{S}}^{\times} + 100\text{O}_0^{\times}$
		Electronic Charge Compensation	$2\text{Mo}_{\text{Mo}}^{\times} + 50\text{O}_0^{\times} \xrightarrow{\text{CeO}_2} 2\text{Mo}_{\text{i}}^{\bullet\bullet\bullet\bullet} + 40\text{O}_0^{\times} + \frac{1}{2}\text{O}_2(\text{g}) + 10e'$
		Redox Charge Compensation	$2\text{Mo}_{\text{Mo}}^{\times} + 50\text{O}_0^{\times} \xrightarrow{\text{CeO}_2} 2\text{Mo}_{\text{i}}^{\bullet\bullet\bullet\bullet} + 40\text{O}_0^{\times} + \frac{1}{2}\text{O}_2(\text{g}) + 10\text{Ce}'_{\text{Ce}}$
Ni	Substitutional	Ionic Charge Compensation	$\text{Ni}_{\text{Ni}}^{\times} + \text{O}_0^{\times} \xrightarrow{\text{CeO}_2} \text{Ni}_{\text{Ce}}^{\prime\prime} + \text{V}_0^{\bullet\bullet} + \text{Ce}_{\text{S}}^{\times} + \frac{1}{2}\text{O}_2(\text{g})$
		Electronic Charge Compensation	$\text{Ni}_{\text{Ni}}^{\times} + \text{O}_0^{\times} + \frac{1}{2}\text{O}_2(\text{g}) \xrightarrow{\text{CeO}_2} \text{Ni}_{\text{Ce}}^{\prime\prime} + 2\text{O}_0^{\times} + \text{Ce}_{\text{S}}^{\times} + 2h^{\bullet}$
		Redox Charge Compensation	$\text{Ni}_{\text{Ni}}^{\times} + \text{O}_0^{\times} \xrightarrow{\text{CeO}_2} \text{Ni}_{\text{Ce}}^{\prime\prime} + \text{Ce}_{\text{S}}^{\times} + \text{O}_0^{\times} + 2\text{Ce}'_{\text{Ce}}$
	Interstitial	Ionic Charge Compensation	$2\text{Ni}_{\text{Ni}}^{\times} + 2\text{O}_0^{\times} \xrightarrow{\text{CeO}_2} 2\text{Ni}_{\text{i}}^{\bullet\bullet} + \text{V}_{\text{Ce}}^{\prime\prime\prime\prime} + \text{Ce}_{\text{S}}^{\times} + 2\text{O}_0^{\times}$
		Electronic Charge Compensation	$\text{Ni}_{\text{Ni}}^{\times} + \text{O}_0^{\times} + \frac{1}{2}\text{O}_2(\text{g}) \xrightarrow{\text{CeO}_2} \text{Ni}_{\text{i}}^{\bullet\bullet} + 2\text{O}_0^{\times} + 2e'$
		Redox Charge Compensation	$\text{Ni}_{\text{Ni}}^{\times} + \text{O}_0^{\times} + \frac{1}{2}\text{O}_2 \xrightarrow{\text{CeO}_2} \text{Ni}_{\text{i}}^{\bullet\bullet} + 2\text{O}_0^{\times} + 2\text{Ce}'_{\text{Ce}}$

$\text{M}_{\text{M}}^{\times}$	= Metal on metal lattice site	(0 charge)
O_0^{\times}	= Oxygen ion on oxygen lattice site	(0 charge)
$\text{M}_{\text{M}\dagger}^{\times}$	= Donor dopant (M) metal substitution on metal lattice site (M^{\dagger})	(+ charge)
$\text{M}'_{\text{M}\dagger}$	= Acceptor dopant (M) metal substitution on metal lattice site (M^{\dagger})	(- charge)
$\text{M}_{\text{i}}^{\bullet}$	= Metal in interstitial site	(+ charge)
$\text{M}_{\text{S}}^{\times}$	= Metal removed from lattice by charge compensation and neutralisation at surface	(0 charge)
$\text{V}_{\text{M}}^{\prime}$	= Metal vacancy	(- charge)
$\text{V}_0^{\bullet\bullet}$	= Oxygen vacancy	(+ charge)
Ce'_{Ce}	= $\text{Ce}^{4+} \rightarrow \text{Ce}^{3+}$ reduction	(- charge)
$\text{Ce}^{\bullet}_{\text{Ce}}$	= $\text{Ce}^{3+} \rightarrow \text{Ce}^{4+}$ oxidation	(+ charge)
e'	= Electron	(- charge)
h^{\bullet}	= Hole	(+ charge)
$\frac{1}{2}\text{O}_2$	= Oxygen gas filling or removed from $\text{V}_0^{\bullet\bullet}$	(0 charge)

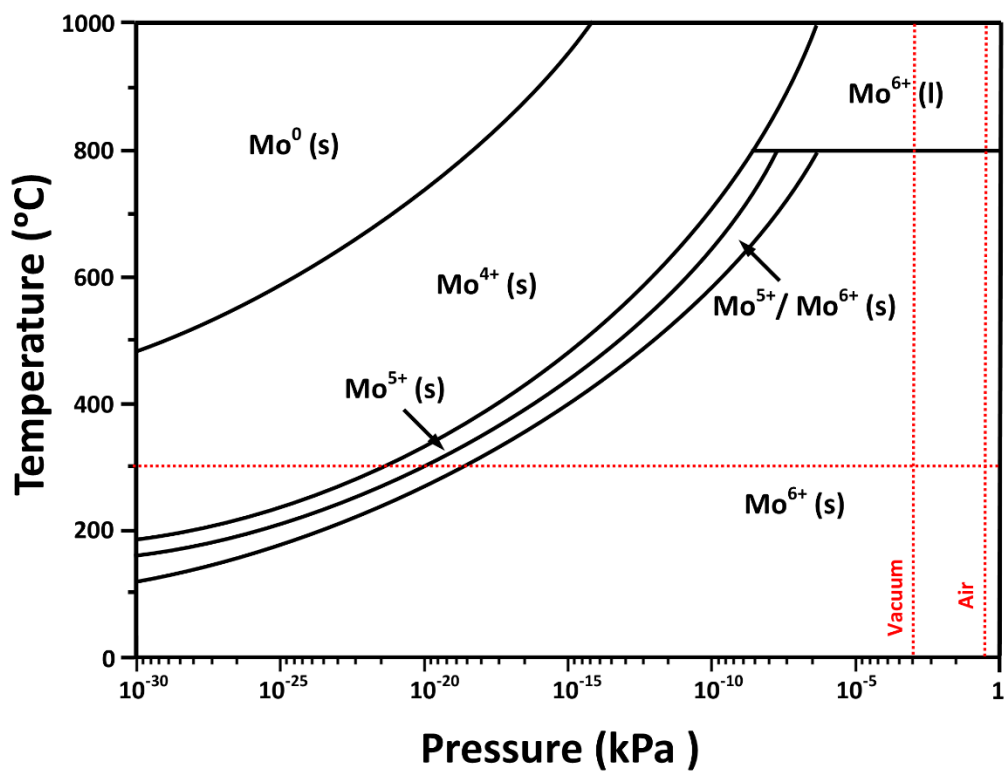


Figure S9 Mo thermodynamic stability diagram (calculated using FactSage)

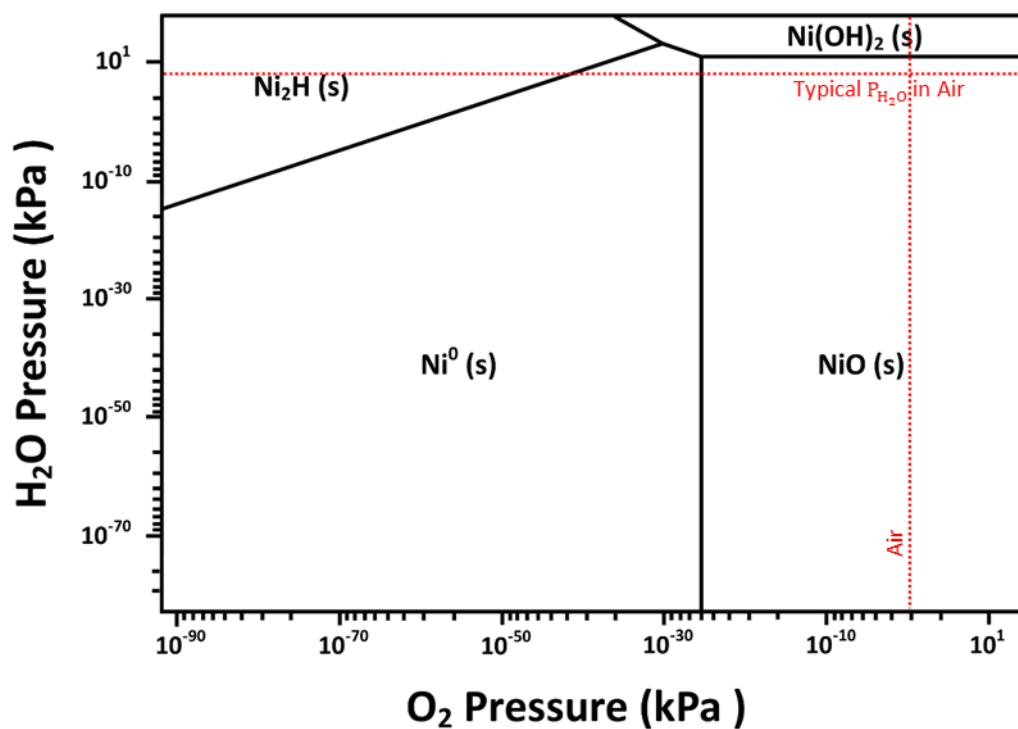


Figure S10 Ni $P_{\text{H}_2\text{O}} - P_{\text{O}_2}$ thermodynamic stability diagram at 300°C (calculated using FactSage)

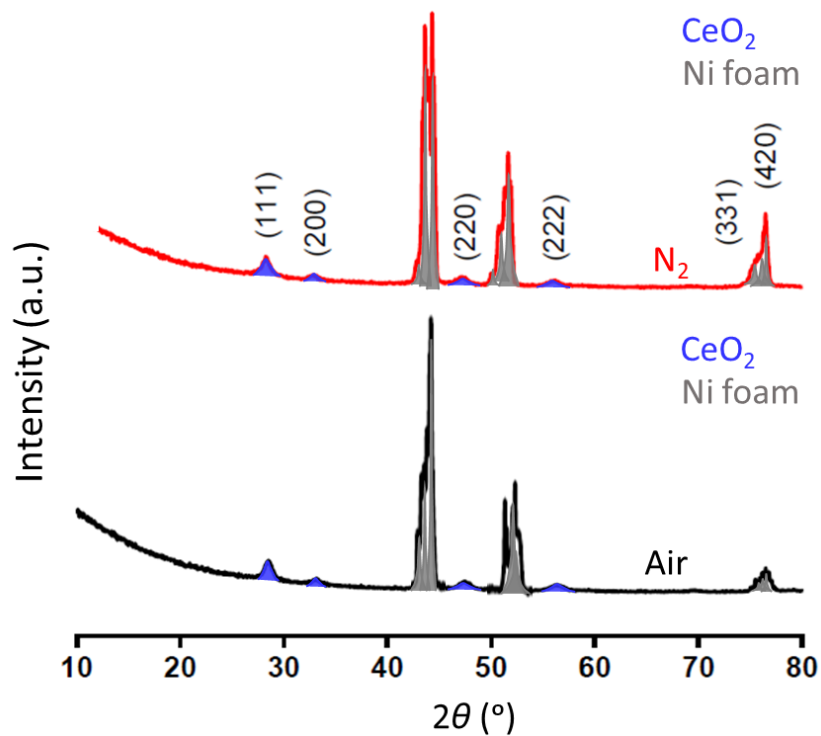


Figure S11 XRD patterns of Air and N₂ on Ni foam (identical intensity scales)

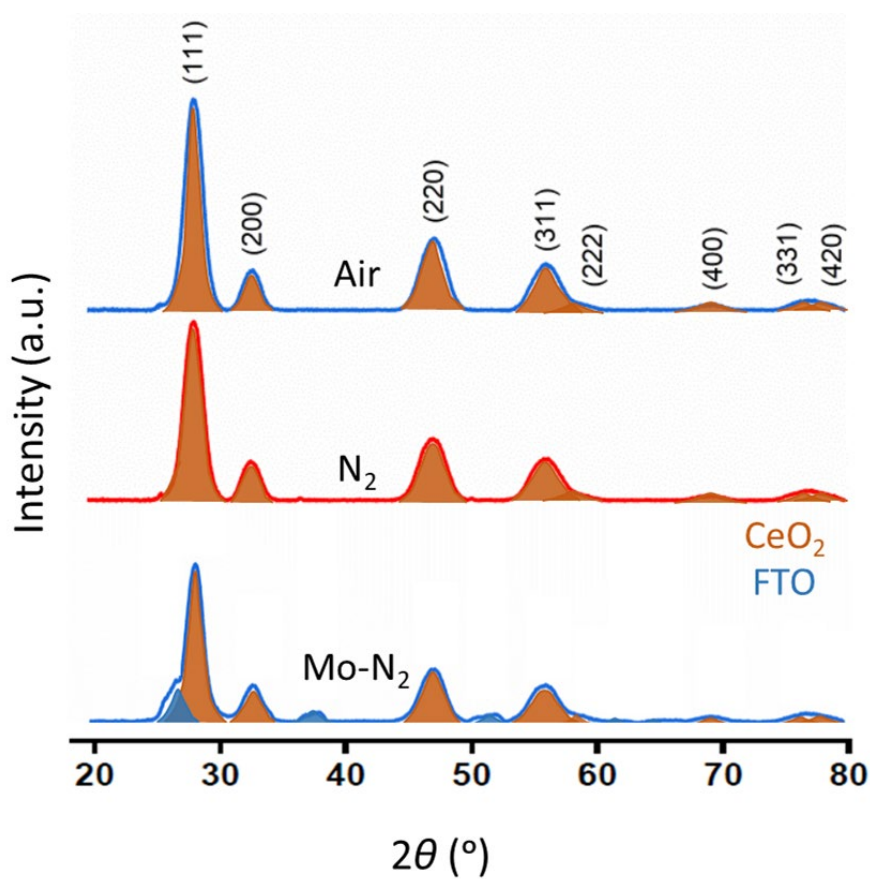


Figure S12 XRD patterns of Air, N₂, and Mo-N₂ on FTO (identical intensity scales)

Table S2 Lattice parameters calculated by Rietveld refinement from XRD data and F_{2g} peak positions from Raman data for Air, N_2 and Mo- N_2 (goodness of fit ≈ 5)

Sample	Lattice Parameter (nm)	F_{2g} Peak Position (cm^{-1})	Relative Shift (cm^{-1})	Surface Stress State
Air	0.5445	461.71	--	--
N_2	0.5421	459.91	-1.18	Tension
Mo- N_2	0.5201	458.71	-3.00	Tension

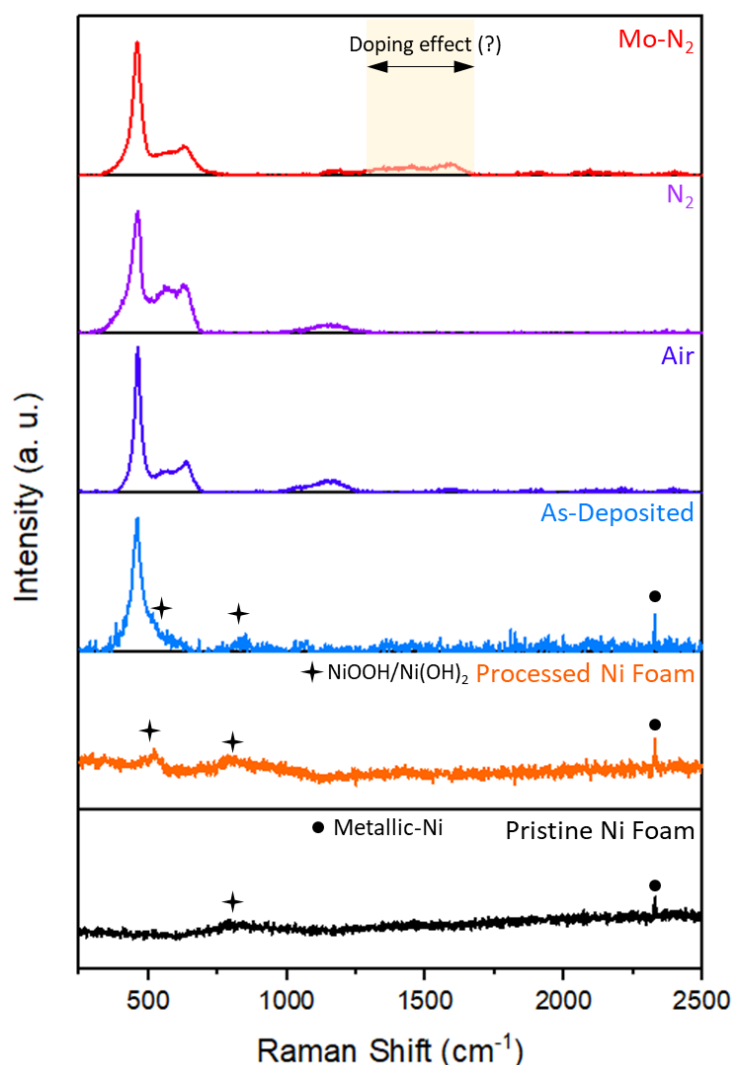


Figure S13 Laser Raman microspectra (the patterns for NiOOH and Ni(OH)₂ cannot be differentiated)

Comparison of the microspectra for Mo- N_2 with those for Air and N_2 reveals shifts in the major F_{2g} peak and the appearance of new peaks in the range 1300-1650 cm^{-1} . The peak at 1360 cm^{-1} is assigned as the 3LO mode (third overtone band of longitudinal optic mode).²⁷ These peaks have been observed previously for doped CeO_{2-x} , albeit for other dopant ions.²⁷⁻³⁰

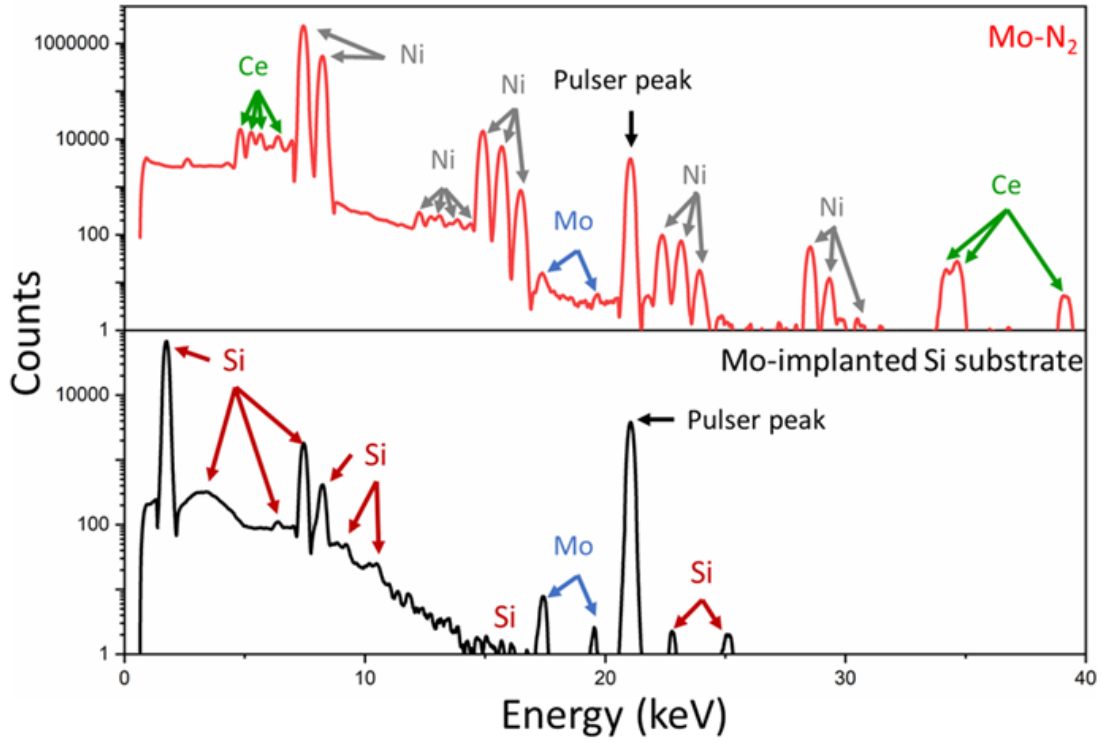


Figure S14 Proton Induced X-ray Emission Spectroscopy (PIXE)

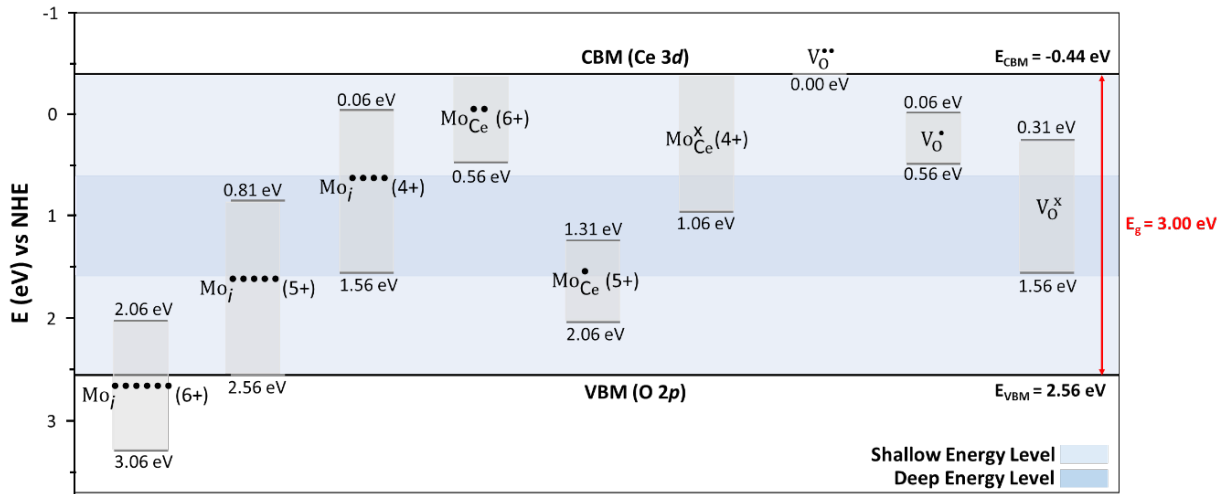


Figure S15 Comprehensive defect energy level diagram for intrinsic and extrinsic defects of different valence states for Mo-doped CeO_2 based on spin-polarized DFT calculations

Table S3 Summary of work on pure and doped of CeO₂ for supercapacitors

Row	Sample	Specific Capacitance	Capacitance after Cycling	Ref.
1	CeO ₂ -Ni foam	582 F·g ⁻¹ at 1 mV·s ⁻¹	92.0% after 2000 cycles	Present work
2	Undoped CeO ₂	135 F·g ⁻¹ at 1 A·g ⁻¹	92.5% after 1000 cycles	31
3	CeO ₂ -Ni foam	225 F·g ⁻¹ at 5 mV·s ⁻¹	--	32
4	CeO ₂ nanoparticles/graphene	208 F·g ⁻¹ at 1 A·g ⁻¹	97.6% after 1000 cycles	33
5	CeO ₂ -5% graphene	110 F·g ⁻¹ at 10 mV·s ⁻¹	--	34
6	CeO ₂ nanoparticles/graphene	208 F·g ⁻¹ at 1 A·g ⁻¹	97.0% after 2000 cycles	27
7	Reduced graphene oxide (rGO)/CeO ₂	265 F·g ⁻¹ at 5 mV·s ⁻¹	96.0% after 1000 cycles	35
8	CeO ₂ mesoporous microspheres	142.5 F·g ⁻¹ at 0.25 A·g ⁻¹	75.0% after 1000 cycles	36
9	Hollow CeO ₂ nanospheres on graphitic carbon	501 F·g ⁻¹ at 1 A·g ⁻¹	93.0% after 5000 cycles	37
10	Mo (0.01 mol%)-CeO ₂ -Ni foam	746 F·g ⁻¹ at 1 mV·s ⁻¹	95.0% after 2000 cycles	Present Work
11	Ni-doped CeO ₂	446 F·g ⁻¹ at 1 A·g ⁻¹	97.5% after 2000 cycles	38
12	Mg-doped CeO ₂	432 F·g ⁻¹ at 1 A·g ⁻¹	89.0% after 10,000 cycles	39
13	Ni-doped CeO ₂	577 F·g ⁻¹ at 2 A·g ⁻¹	94.0% after 1000 cycles	40
14	carbon/Ni-doped CeO ₂	253 F·g ⁻¹ at 0.25 A·g ⁻¹	94.0% after 1000 cycles	41
15	CeO ₂ -SnO ₂ /rGO-Ni foam	156 F·g ⁻¹ at 0.5 A·g ⁻¹	92.0% after 1000 cycles	42
16	Zn-doped CeO ₂ quantum dots	358 F·g ⁻¹ at 10 A·g ⁻¹	96.0% after 1000 cycles	43
17	CeO ₂ -α-MnO ₂ -rGO	466 F·g ⁻¹ at 1 A·g ⁻¹	100.0% after 10000 cycles	44
18	Co (5 mol%)-doped CeO ₂	573 F·g ⁻¹ at 2 A·g ⁻¹	96.0% after 1000 cycles	45

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